

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination DAVIES ET AL.	
		Examiner Tan Dean D. Nguyen	Art Unit 3629	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2,002,015	05-1935	JOHANNES KOSTEN; et. al.	359/544
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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I	US-			
J	US-			
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M	US-			

FOREIGN PATENT DOCUMENTS

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N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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